

Issue Classification

Application/Control No.

10761454

Applicant(s)/Patent Under Reexamination

FUJISAWA, EIZO

Examiner

Dabney, Phylesha L

Art Unit

2614

ORIGINAL

CLASS

SUBCLASS

379

433.13

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

379

433.11

455

575.4

INTERNATIONAL CLASSIFICATION

CLAIMED

NON-CLAIMED

H 0 4 M

1 / 00 (2006.01.01)

H 0 4 M

9 / 00 (2006.01.01)

Dabney, P L

12/10/07

(Assistant Examiner)

(Date)

Total Claims Allowed:

19

(Legal Instruments Examiner)

(Date)

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O.G. Print Claim(s)

7

O.G. Print Figure

1